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Understanding [Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details

Product Status	Obsolete
Number of LABs/CLBs	295
Number of Logic Elements/Cells	-
Total RAM Bits	-
Number of I/O	57
Number of Gates	1200
Voltage - Supply	4.5V ~ 5.5V
Mounting Type	Through Hole
Operating Temperature	0°C ~ 70°C (TA)
Package / Case	84-BCPGA
Supplier Device Package	84-CPGA (28x28)
Purchase URL	https://www.e-xfl.com/product-detail/microsemi/a1010b-1pg84c

DESC SMD/Actel Part Number Cross Reference

Actel Part Number (Gold Leads)	DSCC SMD (Gold Leads)	DSCC SMD (Solder Dipped)
A1010B-PG84B	5962-9096403MXC	5962-9096403MXA
A1010B-1PG84B	5962-9096404MXC	5962-9096404MXA
A1020B-PG84B	5962-9096503MUC	5962-9096503MUA
A1020B-1PG84B	5962-9096504MUC	5962-9096504MUA
A1020B-CQ84B	5962-9096503MTC	5962-9096503MTA
A1020B-1CQ84B	5962-9096504MTC	5962-9096504MTA
A1240A-PG132B	5962-9322101MXC	5962-9322101MXA
A1240A-1PG132B	5962-9322102MXC	5962-9322102MXA
A1280A-PG176B	5962-9215601MXC	5962-9215601MXA
A1280A-1PG176B	5962-9215602MXC	5962-9215602MXA
A1280A-CQ172B	5962-9215601MYC	5962-9215601MYA
A1280A-1CQ172B	5962-9215602MYC	5962-9215602MYA
A1425A-PG133B	5962-9552001MXC	N/A
A1425A-1PG133B	5962-9552002MXC	N/A
A1425A-CQ132B	5962-9552001MYC	N/A
A1425A-1CQ132B	5962-9552002MYC	N/A
A1460A-PG207B	5962-9550801MXC	N/A
A1460A-1PG207B	5962-9550802MXC	N/A
A1460A-CQ196B	5962-9550801MYC	N/A
A1460A-1CQ196B	5962-9550802MYC	N/A
A14100A-PG257B	5962-9552101MXC	N/A
A14100A-1PG257B	5962-9552102MXC	N/A
A14100A-CQ256B	5962-9552101MYC	N/A
A14100A-1CQ256B	5962-9552102MYC	N/A
A32100DX-CQ84B	5962-9875901QXC	N/A
A32100DX-1CQ84B	5962-9857902QXC	N/A
A32200DX-CQ256B	5962-9952701QXC	N/A
A32200DX-1CQ256B	5962-9952702QXC	N/A
A32200DX-CQ208B	5962-9952701QYC	N/A
A32200DX-1CQ208B	5962-9952702QYC	N/A

Package Thermal Characteristics

The device junction to case thermal characteristic is θ_{jc} , and the junction to ambient air characteristic is θ_{ja} . The thermal characteristics for θ_{ja} are shown with two different air flow rates.

Maximum junction temperature is 150°C.

A sample calculation of the absolute maximum power dissipation allowed for a CPGA 176-pin package at military temperature is as follows:

$$\frac{\text{Max. junction temp. (°C)} - \text{Max. military temp.}}{\theta_{ja} \text{ (°C/W)}} = \frac{150^\circ\text{C} - 125^\circ\text{C}}{23^\circ\text{C/W}} = 1.1 \text{ W}$$

Package Type	Pin Count	θ_{jc}	θ_{ja} Still Air	θ_{ja} 300 ft/min	Units
Ceramic Pin Grid Array	84	6.0	33	20	°C/W
	132	4.8	25	16	°C/W
	133	4.8	25	15	°C/W
	176	4.6	23	12	°C/W
	207	3.5	21	10	°C/W
	257	2.8	15	8	°C/W
Ceramic Quad Flat Pack	84	7.8	40	30	°C/W
	132	7.2	35	25	°C/W
	172	6.8	25	20	°C/W
	196	6.4	23	15	°C/W
	256	6.2	20	10	°C/W

Power Dissipation

General Power Equation

$$P = [I_{CC\text{standby}} + I_{CC\text{active}}] * V_{CC} + I_{OL} * V_{OL} * N + I_{OH} * (V_{CC} - V_{OH}) * M$$

where:

$I_{CC\text{standby}}$ is the current flowing when no inputs or outputs are changing.

$I_{CC\text{active}}$ is the current flowing due to CMOS switching.

I_{OL} , I_{OH} are TTL sink/source currents.

V_{OL} , V_{OH} are TTL level output voltages.

N equals the number of outputs driving TTL loads to V_{OL} .

M equals the number of outputs driving TTL loads to V_{OH} .

Accurate values for N and M are difficult to determine because they depend on the family type, on the design, and on the system I/O. The power can be divided into two components—static and active.

Static Power Component

Actel FPGAs have small static power components that result in power dissipation lower than that of PALs or PLDs. By integrating multiple PALs or PLDs into one FPGA, an even greater reduction in board-level power dissipation can be achieved.

The power due to standby current is typically a small component of the overall power. Standby power is calculated below for commercial, worst-case conditions.

Family	I_{CC}	V_{CC}	Power
ACT 3	2 mA	5.25V	10.5 mW
1200XL/3200DX	2 mA	5.25V	10.5 mW
ACT 2	2 mA	5.25V	10.5 mW
ACT 1	3 mA	5.25V	15.8 mW

The static power dissipated by TTL loads depends on the number of outputs driving high or low and the DC load current. Again, this value is typically small. For instance, a 32-bit bus sinking 4 mA at 0.33V will generate 42 mW with all outputs driving low, and 140 mW with all outputs driving high.

Active Power Component

Power dissipation in CMOS devices is usually dominated by the active (dynamic) power dissipation. This component is frequency dependent, a function of the logic and the external I/O. Active power dissipation results from charging internal chip capacitances of the interconnect, unprogrammed antifuses, module inputs, and module outputs, plus external capacitance due to PC board traces and load device inputs. An additional component of the active power dissipation is the totempole current in CMOS transistor pairs. The net effect can be associated with an equivalent capacitance that

can be combined with frequency and voltage to represent active power dissipation.

Equivalent Capacitance

The power dissipated by a CMOS circuit can be expressed by Equation 1:

$$\text{Power (uW)} = C_{EQ} * V_{CC}^2 * F \quad (1)$$

where:

- C_{EQ} = Equivalent capacitance in pF
- V_{CC} = Power supply in volts (V)
- F = Switching frequency in MHz

Equivalent capacitance is calculated by measuring I_{CC} active at a specified frequency and voltage for each circuit component of interest. Measurements are made over a range of frequencies at a fixed value of V_{CC} . Equivalent capacitance is frequency independent so that the results can be used over a wide range of operating conditions. Equivalent capacitance values are shown below.

CEQ Values for Actel FPGAs

	1200XL			
	ACT 3	3200DX	ACT 2	ACT 1
Modules (C_{EQM})	6.7	5.2	5.8	3.7
Input Buffers (C_{EQI})	7.2	11.6	12.9	22.1
Output Buffers (C_{EQO})	10.4	23.8	23.8	31.2
Routed Array Clock Buffer Loads (C_{EQCR})	1.6	3.5	3.9	4.6
Dedicated Clock Buffer Loads (C_{EQCD})	0.7	N/A	N/A	N/A
I/O Clock Buffer Loads (C_{EQCI})	0.9	N/A	N/A	N/A

To calculate the active power dissipated from the complete design, the switching frequency of each part of the logic must be known. Equation 2 shows a piecewise linear summation over all components that applies to all ACT 1, 1200XL, 3200DX, ACT 2, and ACT 3 devices. Since the ACT 1 family has only one routed array clock, the terms labeled routed_Clk2, dedicated_Clk, and IO_Clk do not apply. Similarly, the ACT 2 family has two routed array clocks, and the dedicated_Clk and IO_Clk terms do not apply. For ACT 3 devices, all terms will apply.

$$\text{Power} = V_{CC}^2 * [(m * C_{EQM} * f_m)_{\text{modules}} + (n * C_{EQI} * f_n)_{\text{inputs}} + (p * (C_{EQO} + C_L) * f_p)_{\text{outputs}} + 0.5 * (q_1 * C_{EQCR} * f_{q1})_{\text{routed_Clk1}} + (r_1 * f_{q1})_{\text{routed_Clk1}} + 0.5 * (q_2 * C_{EQCR} * f_{q2})_{\text{routed_Clk2}} + (r_2 * f_{q2})_{\text{routed_Clk2}} + 0.5 * (s_1 * C_{EQCD} * f_{s1})_{\text{dedicated_Clk}} + (s_2 * C_{EQCI} * f_{s2})_{\text{IO_Clk}}] \quad (2)$$

where:

- m = Number of logic modules switching at f_m
- n = Number of input buffers switching at f_n
- p = Number of output buffers switching at f_p
- q_1 = Number of clock loads on the first routed array clock (all families)
- q_2 = Number of clock loads on the second routed array clock (ACT 2, 1200XL, 3200DX, ACT 3 only)
- r_1 = Fixed capacitance due to first routed array clock (all families)
- r_2 = Fixed capacitance due to second routed array clock (ACT 2, 1200XL, 3200DX, ACT 3 only)
- s_1 = Fixed number of clock loads on the dedicated array clock (ACT 3 only)
- s_2 = Fixed number of clock loads on the dedicated I/O clock (ACT 3 only)
- C_{EQM} = Equivalent capacitance of logic modules in pF
- C_{EQI} = Equivalent capacitance of input buffers in pF
- C_{EQO} = Equivalent capacitance of output buffers in pF
- C_{EQCR} = Equivalent capacitance of routed array clock in pF
- C_{EQCD} = Equivalent capacitance of dedicated array clock in pF
- C_{EQCI} = Equivalent capacitance of dedicated I/O clock in pF
- C_L = Output lead capacitance in pF
- f_m = Average logic module switching rate in MHz
- f_n = Average input buffer switching rate in MHz
- f_p = Average output buffer switching rate in MHz
- f_{q1} = Average first routed array clock rate in MHz (all families)
- f_{q2} = Average second routed array clock rate in MHz (ACT 2, 1200XL, 3200DX, ACT 3 only)
- f_{s1} = Average dedicated array clock rate in MHz (ACT 3 only)
- f_{s2} = Average dedicated I/O clock rate in MHz (ACT 3 only)

Fixed Capacitance Values for Actel FPGAs (pF)

Device Type	r ₁ routed_Clk1	r ₂ routed_Clk2
A1010B	41	n/a
A1020B	69	n/a
A1240A	134	134
A1280A	168	168
A1280XL	168	168
A1425A	75	75
A1460A	165	165
A14100A	195	195
A32100DX	178	178
A32200DX	230	230

Fixed Clock Loads (s₁/s₂—ACT 3 Only)

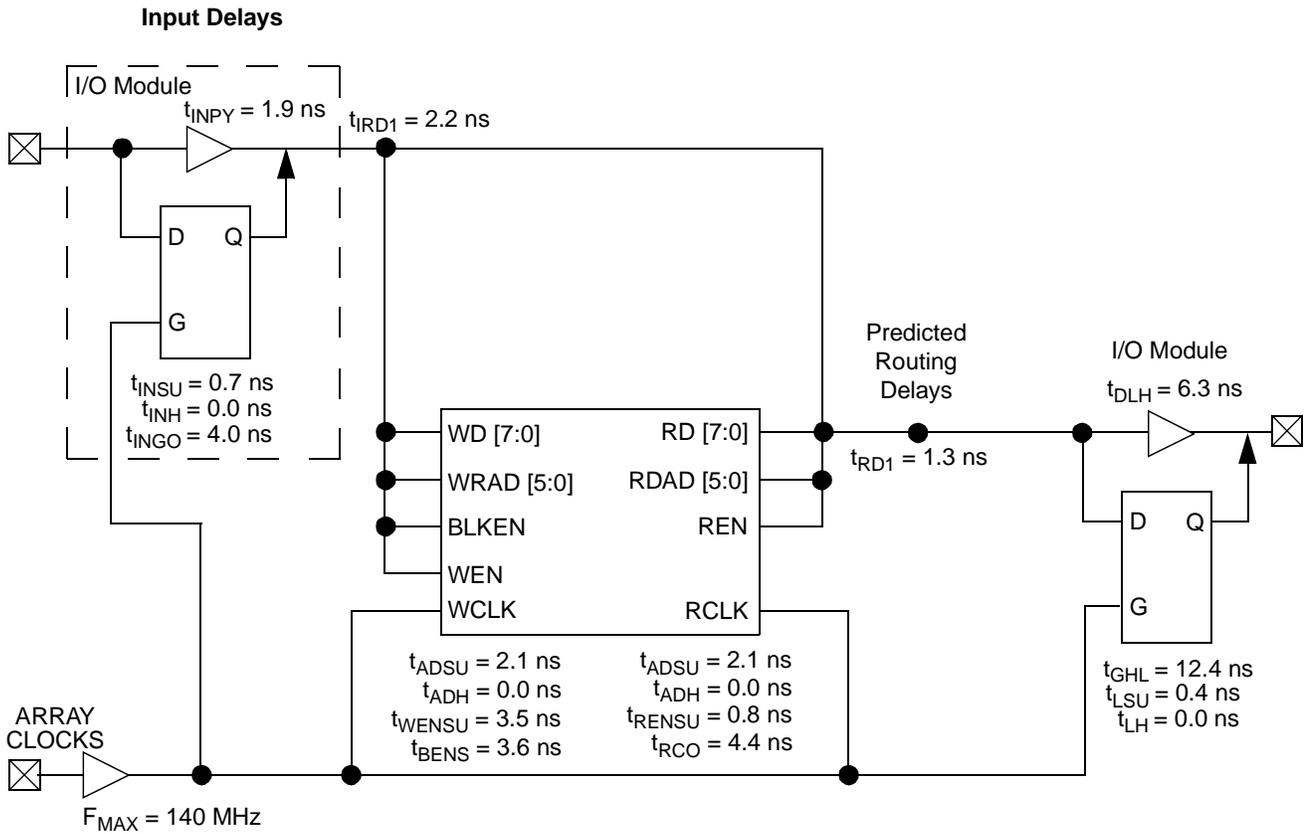
Device Type	s ₁ Clock Loads on Dedicated Array Clock	s ₂ Clock Loads on Dedicated I/O Clock
A1425A	160	100
A1460A	432	168
A14100A	697	228

Determining Average Switching Frequency

To determine the switching frequency for a design, you must have a detailed understanding of the data values input to the circuit. The guidelines in the table below are meant to represent worst-case scenarios so that they can be generally used to predict the upper limits of power dissipation.

Type	ACT 3	3200DX/ACT 2/1200XL	ACT 1
Logic modules (m)	80% of modules	80% of modules	90% of modules
Input switching (n)	# inputs/4	# inputs/4	# inputs/4
Outputs switching (p)	#outputs/4	#outputs/4	#outputs/4
First routed array clock loads (q ₁)	40% of sequential modules	40% of sequential modules	40% of modules
Second routed array clock loads (q ₂)	40% of sequential modules	40% of sequential modules	n/a
Load capacitance (C _L)	35 pF	35 pF	35 pF
Average logic module switching rate (f _m)	F/10	F/10	F/10
Average input switching rate (f _n)	F/5	F/5	F/5
Average output switching rate (f _p)	F/10	F/10	F/10
Average first routed array clock rate (f _{q1})	F/2	F	F
Average second routed array clock rate (f _{q2})	F/2	F/2	n/a
Average dedicated array clock rate (f _{s1})	F	n/a	n/a
Average dedicated I/O clock rate (f _{s2})	F	n/a	n/a

3200DX Timing Model (SRAM Functions)*



*Values shown for A32100DX-1 at worst-case military conditions.

A1280A Timing Characteristics (continued)

(Worst-Case Military Conditions, $V_{CC} = 4.5V$, $T_J = 125^{\circ}C$)

Parameter	Description	'-1' Speed		'Std' Speed		Units
		Min.	Max.	Min.	Max.	
TTL Output Module Timing¹						
t _{DLH}	Data to Pad High		11.0		13.0	ns
t _{DHL}	Data to Pad Low		13.9		16.4	ns
t _{ENZH}	Enable Pad Z to High		12.3		14.4	ns
t _{ENZL}	Enable Pad Z to Low		16.1		19.0	ns
t _{ENHZ}	Enable Pad High to Z		9.8		11.5	ns
t _{ENLZ}	Enable Pad Low to Z		11.5		13.6	ns
t _{GLH}	G to Pad High		12.4		14.6	ns
t _{GHL}	G to Pad Low		15.5		18.2	ns
d _{TLH}	Delta Low to High		0.09		0.11	ns/pF
d _{THL}	Delta High to Low		0.17		0.20	ns/pF
CMOS Output Module Timing¹						
t _{DLH}	Data to Pad High		14.0		16.5	ns
t _{DHL}	Data to Pad Low		11.7		13.7	ns
t _{ENZH}	Enable Pad Z to High		12.3		14.4	ns
t _{ENZL}	Enable Pad Z to Low		16.1		19.0	ns
t _{ENHZ}	Enable Pad High to Z		9.8		11.5	ns
t _{ENLZ}	Enable Pad Low to Z		11.5		13.6	ns
t _{GLH}	G to Pad High		12.4		14.6	ns
t _{GHL}	G to Pad Low		15.5		18.2	ns
d _{TLH}	Delta Low to High		0.17		0.20	ns/pF
d _{THL}	Delta High to Low		0.12		0.15	ns/pF

Notes:

1. Delays based on 50 pF loading.
2. SSO information can be found in the Simultaneously Switching Output Limits for Actel FPGAs application note at <http://www.actel.com/appnotes>.

A1425A Timing Characteristics (continued)**(Worst-Case Military Conditions, $V_{CC} = 4.5V$, $T_J = 125^{\circ}C$)**

Parameter	Description	'-1' Speed		'Std' Speed		Units
		Min.	Max.	Min.	Max.	
I/O Module Sequential Timing						
t_{INH}	Input F-F Data Hold (w.r.t. IOCLK Pad)	0.0		0.0		ns
t_{INSU}	Input F-F Data Setup (w.r.t. IOCLK Pad)	2.1		2.4		ns
t_{IDEH}	Input Data Enable Hold (w.r.t. IOCLK Pad)	0.0		0.0		ns
t_{IDESU}	Input Data Enable Setup (w.r.t. IOCLK Pad)	8.7		10.0		ns
t_{OUTH}	Output F-F Data Hold (w.r.t. IOCLK Pad)	1.1		1.2		ns
t_{OUTSU}	Output F-F Data Setup (w.r.t. IOCLK Pad)	1.1		1.2		ns
t_{ODEH}	Output Data Enable Hold (w.r.t. IOCLK Pad)	0.5		0.6		ns
t_{ODESU}	Output Data Enable Setup (w.r.t. IOCLK Pad)	2.0		2.4		ns
TTL Output Module Timing¹						
t_{DHS}	Data to Pad, High Slew		7.5		8.9	ns
t_{DLS}	Data to Pad, Low Slew		11.9		14.0	ns
t_{ENZHS}	Enable to Pad, Z to H/L, High Slew		6.0		7.0	ns
t_{ENZLS}	Enable to Pad, Z to H/L, Low Slew		10.9		12.8	ns
t_{ENHSZ}	Enable to Pad, H/L to Z, High Slew		9.9		11.6	ns
t_{ENLSZ}	Enable to Pad, H/L to Z, Low Slew		9.9		11.6	ns
t_{CKHS}	IOCLK Pad to Pad H/L, High Slew		10.5		11.6	ns
t_{CKLS}	IOCLK Pad to Pad H/L, Low Slew		15.7		17.4	ns
d_{TLHHS}	Delta Low to High, High Slew		0.04		0.04	ns/pF
d_{TLHLS}	Delta Low to High, Low Slew		0.07		0.08	ns/pF
d_{THLHS}	Delta High to Low, High Slew		0.05		0.06	ns/pF
d_{THLLS}	Delta High to Low, Low Slew		0.07		0.08	ns/pF

Note:

1. Delays based on 35 pF loading.

A1460A Timing Characteristics (continued)**(Worst-Case Military Conditions, $V_{CC} = 4.5V$, $T_J = 125^{\circ}C$)**

Parameter	Description	'-1' Speed		'Std' Speed		Units
		Min.	Max.	Min.	Max.	
Routed Array Clock Networks						
t_{RCKH}	Input Low to High (FO=256)		9.0		10.5	ns
t_{RCKL}	Input High to Low (FO=256)		9.0		10.5	ns
t_{RPWH}	Min. Pulse Width High (FO=256)	6.3		7.1		ns
t_{RPWL}	Min. Pulse Width Low (FO=256)	6.3		7.1		ns
t_{RCKSW}	Maximum Skew (FO=128)		1.9		2.1	ns
t_{RP}	Minimum Period (FO=256)	12.9		14.5		ns
f_{RMAX}	Maximum Frequency (FO=256)		75		65	MHz
Clock-to-Clock Skews						
$t_{IOHCKSW}$	I/O Clock to H-Clock Skew	0.0	3.0	0.0	3.0	ns
$t_{IORCKSW}$	I/O Clock to R-Clock Skew	0.0	5.0	0.0	5.0	ns
t_{HRCKSW}	H-Clock to R-Clock Skew (FO = 64) (FO = 50% max.)	0.0	1.0	0.0	1.0	ns
		0.0	3.0	0.0	3.0	ns

A14100A Timing Characteristics

(Worst-Case Military Conditions, $V_{CC} = 4.5V$, $T_J = 125^\circ C$)

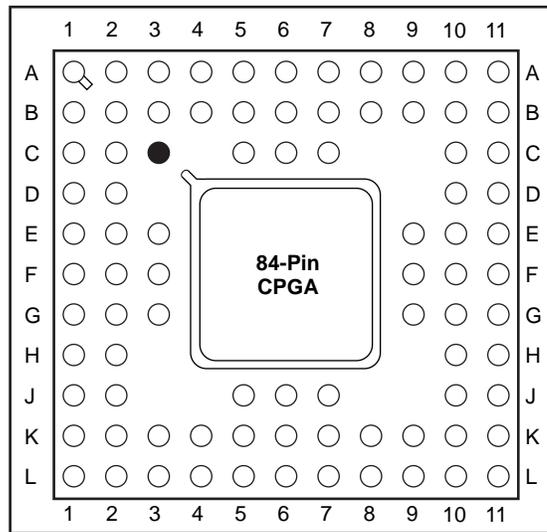
Parameter	Description	'-1' Speed		'Std' Speed		Units
		Min.	Max.	Min.	Max.	
Logic Module Propagation Delays¹						
t_{PD}	Internal Array Module		3.0		3.5	ns
t_{CO}	Sequential Clock to Q		3.0		3.5	ns
t_{CLR}	Asynchronous Clear to Q		3.0		3.5	ns
Logic Module Predicted Routing Delays²						
t_{RD1}	FO=1 Routing Delay		1.3		1.5	ns
t_{RD2}	FO=2 Routing Delay		1.9		2.1	ns
t_{RD3}	FO=3 Routing Delay		2.1		2.5	ns
t_{RD4}	FO=4 Routing Delay		2.6		2.9	ns
t_{RD8}	FO=8 Routing Delay		4.2		4.9	ns
Logic Module Sequential Timing						
t_{SUD}	Flip-Flop (Latch) Data Input Setup	1.0		1.0		ns
t_{HD}	Flip-Flop (Latch) Data Input Hold	0.6		0.6		ns
t_{SUENA}	Flip-Flop (Latch) Enable Setup	1.0		1.0		ns
t_{HENA}	Flip-Flop (Latch) Enable Hold	0.6		0.6		ns
t_{WASYN}	Asynchronous Pulse Width	4.8		5.6		ns
t_{WCLKA}	Flip-Flop Clock Pulse Width	4.8		5.6		ns
t_A	Flip-Flop Clock Input Period	9.9		11.6		ns
f_{MAX}	Flip-Flop Clock Frequency		100		85	MHz
Input Module Propagation Delays						
t_{INY}	Input Data Pad to Y		4.2		4.9	ns
t_{ICKY}	Input Reg IOCLK Pad to Y		7.0		8.2	ns
t_{OCKY}	Output Reg IOCLK Pad to Y		7.0		8.2	ns
t_{ICLRY}	Input Asynchronous Clear to Y		7.0		8.2	ns
t_{OCLRY}	Output Asynchronous Clear to Y		7.0		8.2	ns
Input Module Predicted Routing Delays^{2, 3}						
t_{IRD1}	FO=1 Routing Delay		1.3		1.5	ns
t_{IRD2}	FO=2 Routing Delay		1.9		2.1	ns
t_{IRD3}	FO=3 Routing Delay		2.1		2.5	ns
t_{IRD4}	FO=4 Routing Delay		2.6		2.9	ns
t_{IRD8}	FO=8 Routing Delay		4.2		4.9	ns

Notes:

1. For dual-module macros, use $t_{PD} + t_{RD1} + t_{PDn}$, $t_{CO} + t_{RD1} + t_{PDn}$, or $t_{PD1} + t_{RD1} + t_{SUD}$, whichever is appropriate.
2. Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual worst-case performance. Post-route timing is based on actual routing delay measurements performed on the device prior to shipment.
3. Optimization techniques may further reduce delays by 0 to 4 ns.

Package Pin Assignments

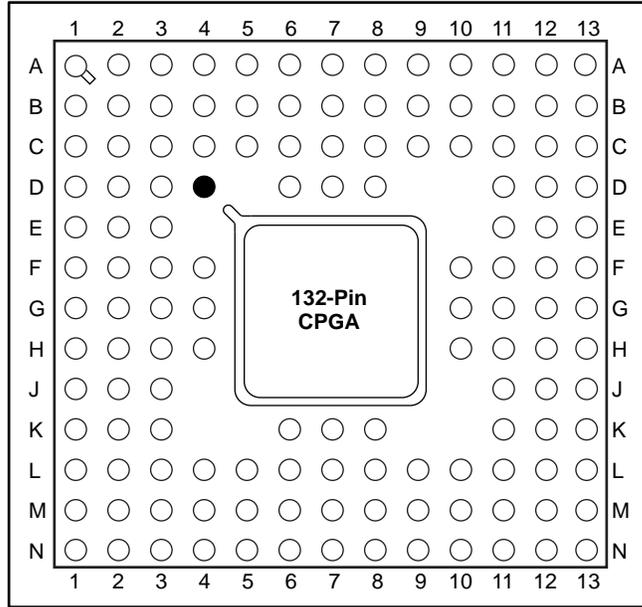
84-Pin CPGA (Top View)



● Orientation Pin (C3)

Package Pin Assignments (continued)

132-Pin CPGA (Top View)



● Orientation Pin

133-Pin CPGA

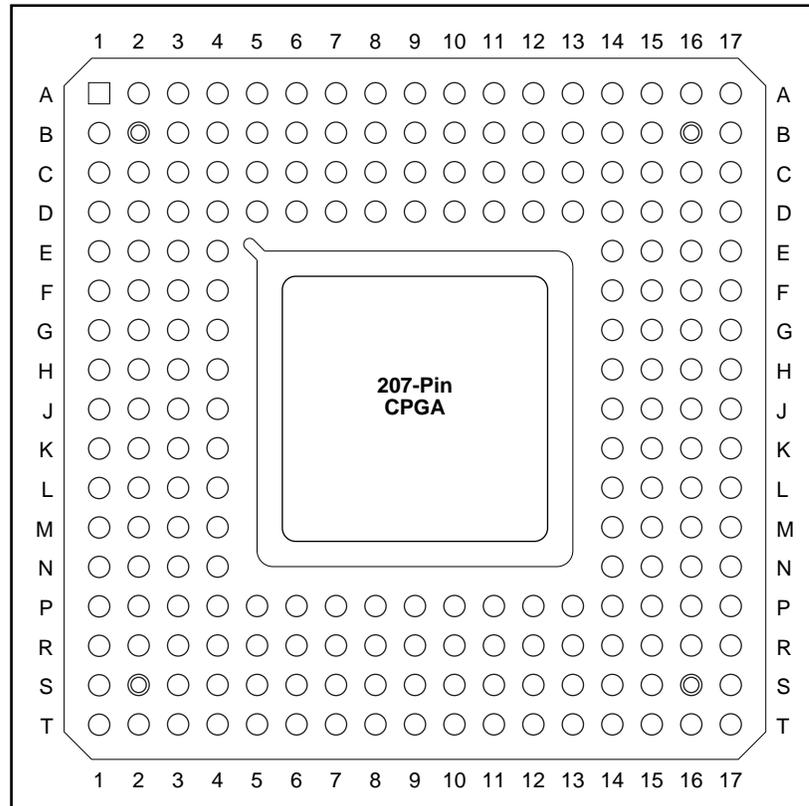
Pin Number	A1425A Function
A1	NC
A2	GND
A3	I/O
A4	I/O
A5	I/O
A6	PRA, I/O
A7	NC
A8	I/O
A9	I/O
A10	I/O
A11	I/O
A12	I/O
A13	NC
B1	I/O
B2	V _{CC}
B3	I/O
B4	I/O
B5	I/O
B6	CLKB, I/O
B7	V _{CC}
B8	I/O
B9	I/O
B10	I/O
B11	I/O
B12	V _{CC}
B13	I/O
C1	I/O
C2	SDI, I/O
C3	GND
C4	I/O
C5	I/O
C6	I/O
C7	GND
C8	I/O
C9	I/O
C10	IOCLK, I/O
C11	GND
C12	GND
C13	I/O
D1	I/O
D2	I/O
D3	I/O
D4	DCLK, I/O
D6	CLKA, I/O
D7	I/O

Pin Number	A1425A Function
D8	I/O
D11	I/O
D12	I/O
D13	I/O
E1	I/O
E2	I/O
E3	MODE
E11	V _{CC}
E12	I/O
E13	I/O
F1	I/O
F2	I/O
F3	I/O
F4	I/O
F10	GND
F11	I/O
F12	I/O
F13	I/O
G1	NC
G2	V _{CC}
G3	GND
G4	I/O
G10	I/O
G11	GND
G12	V _{CC}
G13	NC
H1	I/O
H2	I/O
H3	I/O
H4	I/O
H10	I/O
H11	I/O
H12	I/O
H13	I/O
J1	I/O
J2	V _{CC}
J3	I/O
J11	I/O
J12	V _{CC}
J13	I/O
K1	I/O
K2	I/O
K3	I/O
K6	I/O
K7	HCLKA, I/O

Pin Number	A1425A Function
K8	I/O
K11	I/O
K12	I/O
K13	I/O
L1	I/O
L2	I/O
L3	GND
L4	I/O
L5	I/O
L6	PRB, I/O
L7	GND
L8	I/O
L9	I/O
L10	IOPCL, I/O
L11	GND
L12	I/O
L13	I/O
M1	I/O
M2	V _{CC}
M3	GND
M4	I/O
M5	I/O
M6	I/O
M7	V _{CC}
M8	I/O
M9	I/O
M10	I/O
M11	I/O
M12	V _{CC}
M13	I/O
N1	NC
N2	I/O
N3	I/O
N4	I/O
N5	I/O
N6	I/O
N7	NC
N8	I/O
N9	I/O
N10	I/O
N11	I/O
N12	GND
N13	NC

Package Pin Assignments (continued)

207-Pin CPGA (Top View)



207-Pin CPGA

Pin Number	A1460A Function
A1	NC
A2	NC
A3	I/O
A4	I/O
A5	I/O
A6	I/O
A7	I/O
A8	I/O
A9	I/O
A10	I/O
A11	I/O
A12	I/O
A13	I/O
A14	I/O
A15	I/O
A16	NC
A17	NC
B1	NC
B2	V _{CC}
B3	I/O
B4	I/O
B5	I/O
B6	I/O
B7	I/O
B8	I/O
B9	V _{CC}
B10	I/O
B11	I/O
B12	I/O
B13	I/O
B14	I/O
B15	I/O
B16	V _{CC}
B17	NC
C1	NC
C2	NC
C3	SDI, I/O
C4	I/O
C5	I/O
C6	I/O
C7	I/O
C8	I/O
C9	I/O

Pin Number	A1460A Function
C10	I/O
C11	I/O
C12	I/O
C13	I/O
C14	I/O
C15	GND
C16	I/O
C17	I/O
D1	I/O
D2	I/O
D3	I/O
D4	GND
D5	GND
D6	I/O
D7	MODE
D8	I/O
D9	GND
D10	I/O
D11	V _{CC}
D12	I/O
D13	I/O
D14	GND
D15	I/O
D16	I/O
D17	I/O
E1	I/O
E2	I/O
E3	I/O
E4	DCLK, I/O
E14	I/O
E15	I/O
E16	I/O
E17	I/O
F1	I/O
F2	I/O
F3	I/O
F4	I/O
F14	I/O
F15	I/O
F16	I/O
F17	I/O
G1	I/O
G2	I/O

Pin Number	A1460A Function
G3	I/O
G4	I/O
G14	I/O
G15	I/O
G16	I/O
G17	I/O
H1	PRA, I/O
H2	I/O
H3	I/O
H4	I/O
H14	I/O
H15	I/O
H16	I/O
H17	I/O
J1	I/O
J2	V _{CC}
J3	CLKB, I/O
J4	GND
J14	GND
J15	HCLK, I/O
J16	V _{CC}
J17	I/O
K1	CLKA, I/O
K2	I/O
K3	I/O
K4	I/O
K14	I/O
K15	I/O
K16	PRB, I/O
K17	I/O
L1	I/O
L2	I/O
L3	I/O
L4	I/O
L14	I/O
L15	I/O
L16	I/O
L17	I/O
M1	I/O
M2	I/O
M3	I/O
M4	I/O
M14	I/O

172-Pin CQFP

Pin Number	A1280A Function	A1280XL Function
1	MODE	MODE
2	I/O	I/O
3	I/O	I/O
4	I/O	I/O
5	I/O	I/O
6	I/O	I/O
7	GND	GND
8	I/O	I/O
9	I/O	I/O
10	I/O	I/O
11	I/O	I/O
12	V _{CC}	V _{CC}
13	I/O	I/O
14	I/O	I/O
15	I/O	I/O
16	I/O	I/O
17	GND	GND
18	I/O	I/O
19	I/O	I/O
20	I/O	I/O
21	I/O	I/O
22	GND	GND
23	V _{CC}	V _{CC}
24	V _{CC}	V _{CC}
25	I/O	I/O
26	I/O	I/O
27	V _{CC}	V _{CC}
28	I/O	I/O
29	I/O	I/O
30	I/O	I/O
31	I/O	I/O
32	GND	GND
33	I/O	I/O
34	I/O	I/O
35	I/O	I/O
36	I/O	I/O
37	GND	GND
38	I/O	I/O
39	I/O	I/O
40	I/O	I/O
41	I/O	I/O
42	I/O	I/O
43	I/O	I/O
44	I/O	I/O

Pin Number	A1280A Function	A1280XL Function
45	I/O	I/O
46	I/O	I/O
47	I/O	I/O
48	I/O	I/O
49	I/O	I/O
50	V _{CC}	V _{CC}
51	I/O	I/O
52	I/O	I/O
53	I/O	I/O
54	I/O	I/O
55	GND	GND
56	I/O	I/O
57	I/O	I/O
58	I/O	I/O
59	I/O	I/O
60	I/O	I/O
61	I/O	I/O
62	I/O	I/O
63	I/O	I/O
64	I/O	I/O
65	GND	GND
66	V _{CC}	V _{CC}
67	I/O	I/O
68	I/O	I/O
69	I/O	I/O
70	I/O	I/O
71	I/O	I/O
72	I/O	I/O
73	I/O	I/O
74	I/O	I/O
75	GND	GND
76	I/O	I/O
77	I/O	I/O
78	I/O	I/O
79	I/O	I/O
80	V _{CC}	V _{CC}
81	I/O	I/O
82	I/O	I/O
83	I/O	I/O
84	I/O	I/O
85	I/O	I/O
86	I/O	I/O
87	I/O	I/O
88	I/O	I/O

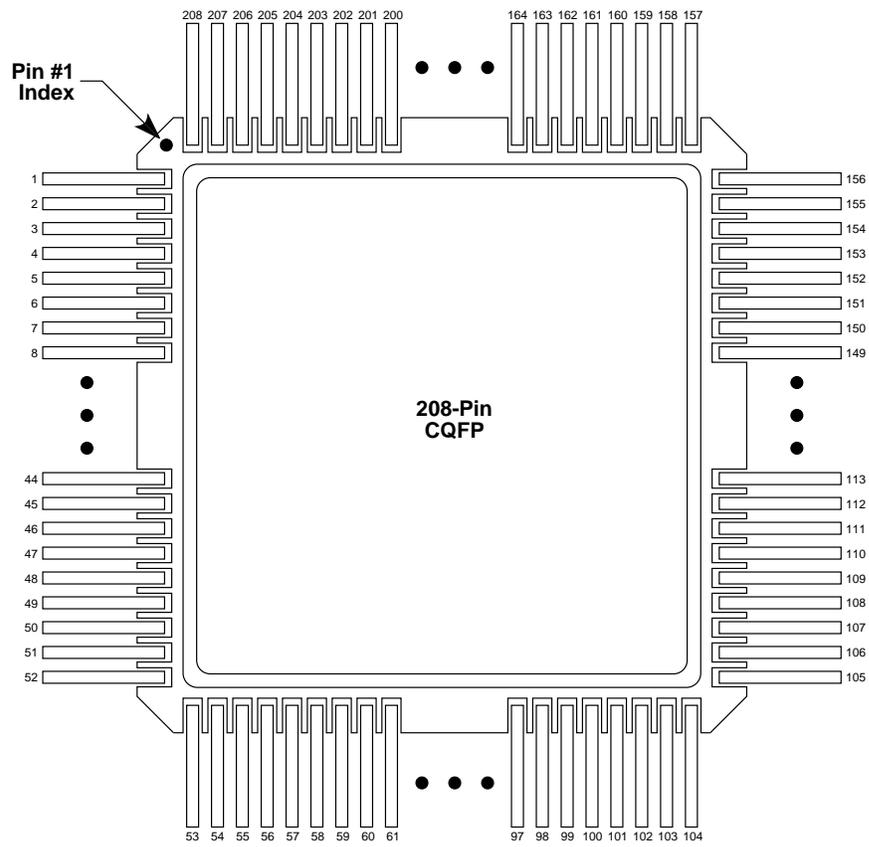
172-Pin CQFP (Continued)

Pin Number	A1280A Function	A1280XL Function
89	I/O	I/O
90	I/O	I/O
91	I/O	I/O
92	I/O	I/O
93	I/O	I/O
94	I/O	I/O
95	I/O	I/O
96	I/O	I/O
97	I/O	I/O
98	GND	GND
99	I/O	I/O
100	I/O	I/O
101	I/O	I/O
102	I/O	I/O
103	GND	GND
104	I/O	I/O
105	I/O	I/O
106	GND	GND
107	V _{CC}	V _{CC}
108	GND	GND
109	V _{CC}	V _{CC}
110	V _{CC}	V _{CC}
111	I/O	I/O
112	I/O	I/O
113	V _{CC}	V _{CC}
114	I/O	I/O
115	I/O	I/O
116	I/O	I/O
117	I/O	I/O
118	GND	GND
119	I/O	I/O
120	I/O	I/O
121	I/O	I/O
122	I/O	I/O
123	GND	GND
124	I/O	I/O
125	I/O	I/O
126	I/O	I/O
127	I/O	I/O
128	I/O	I/O
129	I/O	I/O
130	I/O	I/O

Pin Number	A1280A Function	A1280XL Function
131	SDI, I/O	SDI, I/O
132	I/O	I/O
133	I/O	I/O
134	I/O	I/O
135	I/O	I/O
136	V _{CC}	V _{CC}
137	I/O	I/O
138	I/O	I/O
139	I/O	I/O
140	I/O	I/O
141	GND	GND
142	I/O	I/O
143	I/O	I/O
144	I/O	I/O
145	I/O	I/O
146	I/O	I/O
147	I/O	I/O
148	PRA, I/O	PRA, I/O
149	I/O	I/O
150	CLKA, I/O	CLKA, I/O
151	V _{CC}	V _{CC}
152	GND	GND
153	I/O	I/O
154	CLKB, I/O	CLKB, I/O
155	I/O	I/O
156	PRB, I/O	PRB, I/O
157	I/O	I/O
158	I/O	I/O
159	I/O	I/O
160	I/O	I/O
161	GND	GND
162	I/O	I/O
163	I/O	I/O
164	I/O	I/O
165	I/O	I/O
166	V _{CC}	V _{CC}
167	I/O	I/O
168	I/O	I/O
169	I/O	I/O
170	I/O	I/O
171	DCLK, I/O	DCLK, I/O
172	I/O	I/O

Package Pin Assignments (continued)

208-Pin CQFP (Top View)



208-Pin CQFP

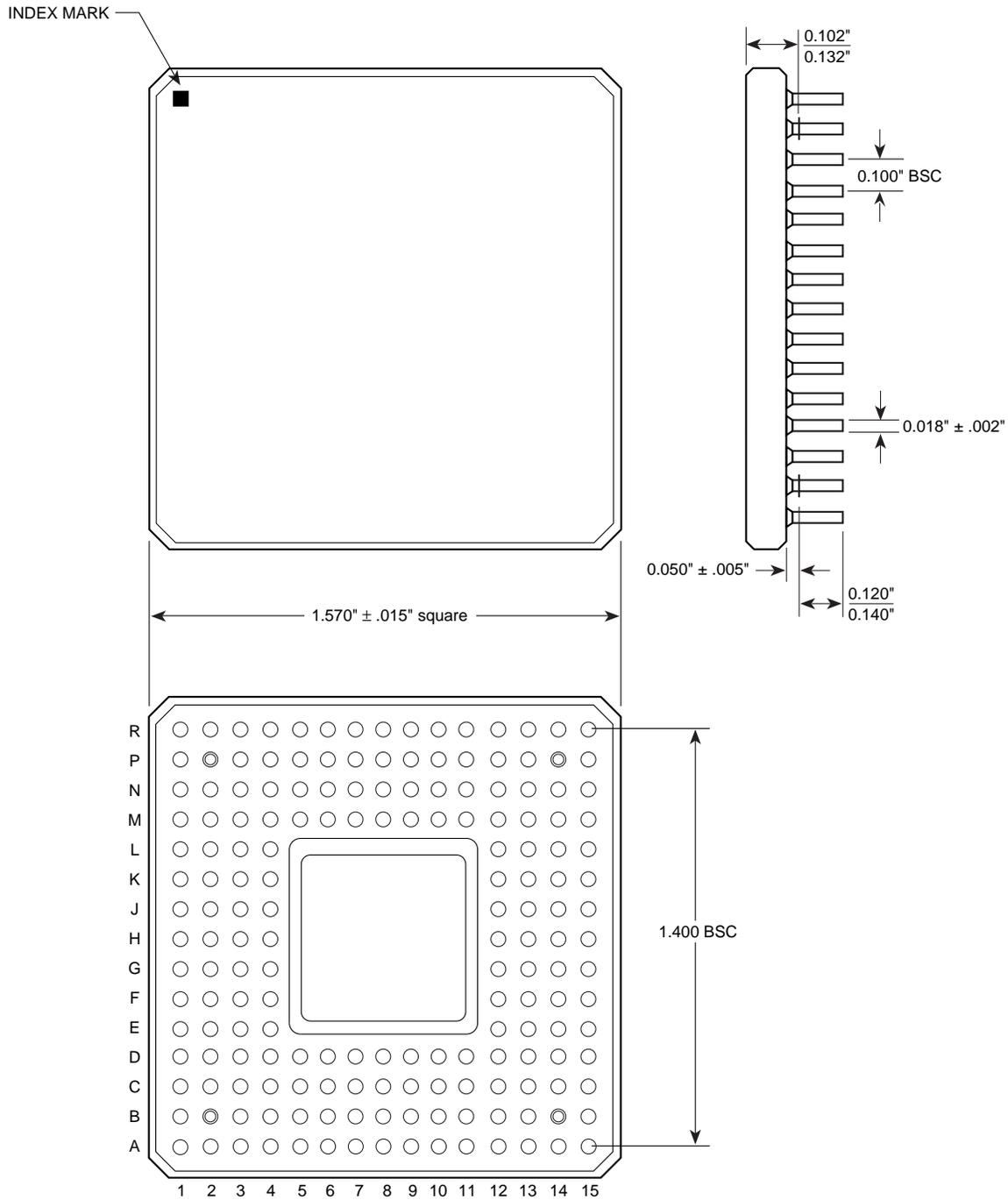
Pin Number	A32100DX Function
1	GND
2	V _{CC}
3	MODE
4	I/O
5	I/O
6	I/O
7	I/O
8	I/O
9	I/O
10	I/O
11	I/O
12	I/O
13	I/O
14	I/O
15	I/O
16	I/O
17	V _{CC}
18	I/O
19	I/O
20	I/O
21	I/O
22	GND
23	I/O
24	I/O
25	I/O
26	I/O
27	GND
28	V _{CC}
29	V _{CC}
30	I/O
31	I/O
32	V _{CC}
33	I/O
34	I/O
35	I/O
36	I/O
37	I/O
38	I/O
39	I/O
40	I/O
41	I/O
42	I/O
43	I/O

Pin Number	A32100DX Function
44	I/O
45	I/O
46	I/O
47	I/O
48	I/O
49	I/O
50	I/O
51	I/O
52	GND
53	GND
54	TMS, I/O
55	TDI, I/O
56	I/O
57	I/O (WD)
58	I/O (WD)
59	I/O
60	V _{CC}
61	I/O
62	I/O
63	I/O
64	I/O
65	QCLKA, I/O
66	I/O (WD)
67	I/O (WD)
68	I/O
69	I/O
70	I/O (WD)
71	I/O (WD)
72	I/O
73	I/O
74	I/O
75	I/O
76	I/O
77	I/O
78	GND
79	V _{CC}
80	V _{CC}
81	I/O
82	I/O
83	I/O
84	I/O
85	I/O (WD)
86	I/O (WD)

Pin Number	A32100DX Function
87	I/O
88	I/O
89	I/O
90	I/O
91	QCLKB, I/O
92	I/O
93	I/O (WD)
94	I/O (WD)
95	I/O
96	I/O
97	I/O
98	V _{CC}
99	I/O
100	I/O (WD)
101	I/O (WD)
102	I/O
103	SDO, I/O
104	I/O
105	GND
106	V _{CC}
107	I/O
108	I/O
109	I/O
110	I/O
111	I/O
112	I/O
113	I/O
114	I/O
115	I/O
116	I/O
117	I/O
118	I/O
119	I/O
120	I/O
121	I/O
122	I/O
123	I/O
124	I/O
125	I/O
126	GND
127	I/O
128	TCK, I/O
129	GND

Package Mechanical Drawings (continued)

176-Pin CPGA



Notes:

1. All dimensions are in inches unless otherwise stated.
2. BSC—Basic Spacing between Centers. This is a theoretical true position dimension and so has no tolerance.